


<b>Search Notes</b>  	<b>Application/Control No.</b>  10616097	<b>Applicant(s)/Patent Under Reexamination</b>  SUN ET AL.
	<b>Examiner</b>  EDNA WONG	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner
205	118	6/1/05	EW
205	123	6/1/05	EW
205	182	6/1/05	EW
205	296	6/1/05	EW

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search	6/1/05	EW
EAST	6/1/05	EW
STN	6/1/05	EW
Search Updated	9/24/05	EW
Search Updated	5/9/06	EW
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Search Updated	7/5/07	EW
Search Updated	11/18/07	EW
Search Updated	3/3/08	EW
Search Updated	8/8/08	EW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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